Searcn Notes			
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1.2.		8 11 8 8 1 15 818 18 81 18 83	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/691,212	DORNBUSCH ET AL.	
Examiner	Art Unit	
Chris C. Chu	2815	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	E23.052, E23.079, 786 & 778	4/13/2006	C.C.
257	686	4/13/2006	C.C.
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		-	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	4/13/2006	C.C.
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